


Search Notes 	Application/Control No. 10579418	Applicant(s)/Patent Under Reexamination STEK ET AL.
	Examiner Huynh, Phuong	Art Unit 2857

SEARCHED			
Class	Subclass	Date	Examiner
702	150	04/17/2007	PH
73	865.9	04/18/2007	PH
324	207.2; 207.25	04/18/2007	PH
UPDATED	ABOVE	08/10/07	PH
702	109-113, 116, 142-147, 151-153, 163	08/10/2007	PH
324	76.12, 76.14	08/10/2007	PH
UPDATED	ABOVE	08/12/2007	PH
341	8, 115	08/12/2007	PH
324	207.12, 207.14; 76.13	08/12/2007	PH
UPDATED	ABOVE	11/19/2007	PH
702	94	11/21/2007	PH

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Primary Examiner Blane Jackson (AU 2618): no search in 455	04/18/2007	PH
Consulted with Primary Examiner Thomas Noland : 73/865.9; 324/207.2, 207.25	04/18/2007	PH
702/150; 73/865.9; 324/207.2, 207.25 with text	04/18/2007	PH
Assignment data (eDan)	04/18/2007	PH
702/109-113, 116, 142-147, 150-153, 163; 324/207.2; 207.25, 76.12, 76.14; 73/865.9 with text	08/10/2007	PH
702/109-113, 116, 142-147, 150-153, 163; 324/207.2; 207.12, 207.14, 207.25, 76.12, 76.13, 76.14; 73/865.9; 341/8, 15 with text	8/12/2007	PH
Assignment data (eDan) updated	11/19/2007	PH
702/109-113, 116, 142-147, 150-153, 163; 324/207.2; 207.12, 207.14, 207.25, 76.12, 76.13, 76.14; 73/865.9; 341/8, 15 with text	11/19/2007	PH
702/94 with text	11/21/2007	PH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	112, 113, 145	08/12/2007	PH
73	865.9	8/12/2007	PH
341	8, 115	8/12/2007	PH
324	207.12; 76.13	8/12/2007	PH
UPDATED	ABOVE	11/19/2007	PH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
702	94	11/21/2007	PH